

## TS3A5018 10Ω、クワッドSPDTアナログ・スイッチ

### 1 特長

- 低いオン抵抗(10Ω)
- 低い電荷注入
- 非常に優れたオン抵抗マッチング
- 低い全高調波歪(THD)
- 1.8V~3.6Vの単電源で動作
- JESD 78, Class II準拠で100mA超のラッチアップ性能
- ESD性能はJESD 22に準拠しテスト済み
  - 人体モデルで2000V (A114-B, クラスII)
  - 荷電デバイス・モデルで1000V (C101)

### 2 アプリケーション

- サンプル・アンド・ホールド回路
- バッテリ駆動の機器
- オーディオおよびビデオ信号のルーティング
- 通信用回路

### 3 概要

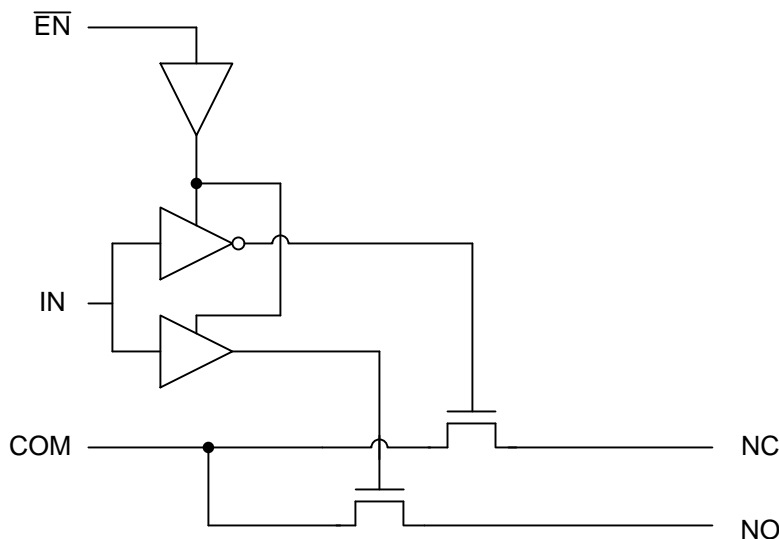
TS3A5018デバイスはクワッド単極双投(SPDT)アナログ・スイッチで、1.8V~3.6Vで動作するよう設計されています。このデバイスはデジタルとアナログの両方の信号を処理でき、 $V_{DD}$ までの信号をどちらの方向にも転送できます。

#### 製品情報<sup>(1)</sup>

型番	パッケージ	本体サイズ(公称)
TS3A5018	SOIC (16)	9.90mm×6.00mm
	SSOP (16)	6.00mm×4.90mm
	TSSOP (16)	5.00mm×4.40mm
	TVSOP (16)	4.40mm×3.60mm
	UQFN (16)	2.50mm×1.80mm
	VQFN (16)	4.00mm×3.50mm

(1) 提供されているすべてのパッケージについては、データシートの末尾にある注文情報を参照してください。

#### ブロック図



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## 4 改訂履歴

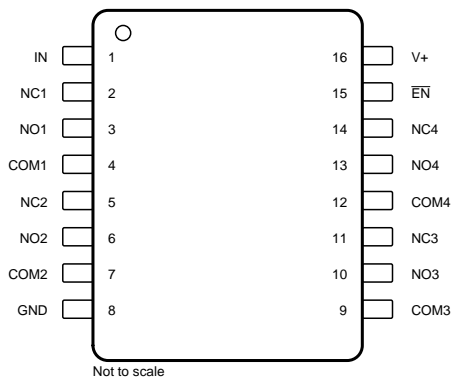
資料番号末尾の英字は改訂を表しています。その改訂履歴は英語版に準じています。

Revision G (March 2015) から Revision H に変更	Page
• Changed the pinout images.....	3
• Changed the $r_{on}$ MAX value at 25°C From: 8 $\Omega$ To: 17 $\Omega$ in the <i>Electrical Characteristics for 1.8-V Supply</i> table.....	7
• Changed the $r_{on}$ MAX value at Full From: 14.55 $\Omega$ To: 32 $\Omega$ in the <i>Electrical Characteristics for 1.8-V Supply</i> table.....	7

Revision F (June 2013) から Revision G に変更	Page
• 「アプリケーション」セクション、「製品情報」表、「ピン機能」表、「ESD定格」表、「熱に関する情報」表、「代表的特性」セクション、「機能説明」セクション、「デバイスの機能モード」セクション、「アプリケーションと実装」セクション、「電源に関する推奨事項」セクション、「レイアウト」セクション、「デバイスおよびドキュメントのサポート」セクション、「メカニカル、パッケージ、および注文情報」セクションを追加.....	1
• 「注文情報」表を削除.....	1

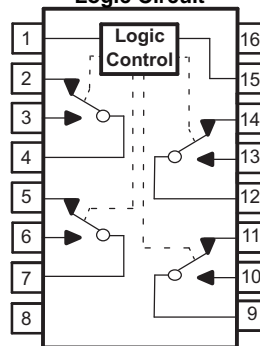
## 5 Pin Configuration and Functions

**D, DBQ, DGV and PW Package  
16-Pin SOIC, SSOP, TVSOP and TSSOP  
(Top View)**

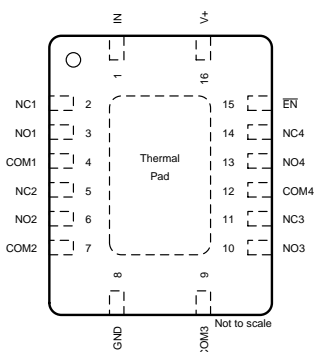


Not to scale

**Logic Circuit**

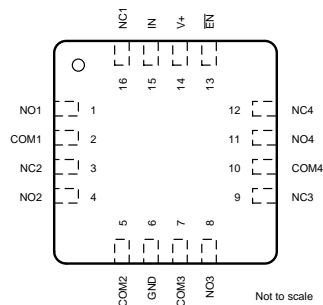


**RGY Package  
16-Pin VQFN  
(Top View)**



Not to scale

**RSV Package  
16-Pin UQFN  
(Top View)**



Not to scale

### Pin Functions

NAME	PIN		TYPE	DESCRIPTION
	SOIC, SSOP, TVSOP, VQFN NO.	UQFN NO.		
COM1	4	2	I/O	Common path for switch
COM2	7	5	I/O	Common path for switch
COM3	9	7	I/O	Common path for switch
COM4	12	10	I/O	Common path for switch
EN	15	13	I	Active-low switch enable input
GND	8	6	—	Ground
IN	1	15	I	Switch path selector input
NC1	2	16	I/O	Normally closed path for switch
NC2	5	3	I/O	Normally closed path for switch
NC3	11	9	I/O	Normally closed path for switch
NC4	14	12	I/O	Normally closed path for switch
NO1	3	1	I/O	Normally open path for switch
NO2	6	4	I/O	Normally open path for switch
NO3	10	8	I/O	Normally open path for switch
NO4	13	11	I/O	Normally open path for switch
V+	16	14	—	Supply voltage

## 6 Specifications

### 6.1 Absolute Maximum Ratings

 over operating free-air temperature range (unless otherwise noted)<sup>(1)(2)</sup>

		MIN	MAX	UNIT		
V <sub>+</sub>	Supply voltage <sup>(3)</sup>	-0.5	4.6	V		
V <sub>NC</sub>	Analog voltage <sup>(3)(4)</sup>	-0.5	4.6	V		
V <sub>NO</sub>						
V <sub>COM</sub>						
I <sub>K</sub>	Analog port diode current	V <sub>NC</sub> , V <sub>NO</sub> , V <sub>COM</sub> < 0		-50	mA	
I <sub>NC</sub>	ON-state switch current	V <sub>NC</sub> , V <sub>NO</sub> , V <sub>COM</sub> = 0 to 7 V		-64	64	mA
I <sub>NO</sub>						
I <sub>COM</sub>						
V <sub>I</sub>	Digital input voltage <sup>(3)(4)</sup>	-0.5	4.6	V		
I <sub>IK</sub>	Digital input clamp current	V <sub>I</sub> < 0		-50	mA	
I <sub>+</sub>	Continuous current through V <sub>+</sub>	-100	100	mA		
I <sub>GND</sub>	Continuous current through GND	-100	100	mA		
T <sub>stg</sub>	Storage temperature	-65	150	°C		

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions* is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) The algebraic convention, whereby the most negative value is a minimum and the most positive value is a maximum
- (3) All voltages are with respect to ground, unless otherwise specified.
- (4) The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

### 6.2 ESD Ratings

		VALUE	UNIT
V <sub>(ESD)</sub>	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>	±2000
		Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup>	±1000

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	MAX	UNIT
V <sub>I/O</sub>	Switch input and output voltage	0	V <sub>+</sub>	V
V <sub>+</sub>	Supply voltage	1.65	3.6	V
V <sub>I</sub>	Control input voltage	0	3.6	V
T <sub>A</sub>	Operating temperature	-40	85	°C

### 6.4 Thermal Information

THERMAL METRIC <sup>(1)</sup>	TS3A5018						UNIT	
	D (SOIC)	DBQ (SSOP)	DGV (TVSOP)	PW (TSSOP)	RGY (VQFN)	RSV (UQFN)		
	16 PINS	16 PINS	16 PINS	16 PINS	16 PINS	16 PINS		
R <sub>θJA</sub>	Junction-to-ambient thermal resistance	73	90	120	108	51	184	°C/W

- (1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

## 6.5 Electrical Characteristics for 3.3-V Supply

 $V_+ = 3\text{ V to }3.6\text{ V}$ ,  $T_A = -40^\circ\text{C to }85^\circ\text{C}$  (unless otherwise noted)<sup>(1)</sup>

PARAMETER		TEST CONDITIONS		$T_A$	$V_+$	MIN	TYP	MAX	UNIT
<b>Analog Switch</b>									
$V_{COM}, V_{NO}, V_{NC}$	Analog signal range					0		$V_+$	V
$r_{on}$	ON-state resistance	$0 \leq (V_{NC} \text{ or } V_{NO}) \leq V_+$ , $I_{COM} = -32\text{ mA}$ ,	Switch ON, see <a href="#">Figure 17</a>	25°C	3 V		7	10	$\Omega$
				Full			12		
$\Delta r_{on}$	ON-state resistance match between channels	$V_{NC} \text{ or } V_{NO} = 2.1\text{ V}$ , $I_{COM} = -32\text{ mA}$ ,	Switch ON, see <a href="#">Figure 17</a>	25°C	3 V		0.3	0.8	$\Omega$
				Full			1		
$r_{on(Flat)}$	ON-state resistance flatness	$0 \leq (V_{NC} \text{ or } V_{NO}) \leq V_+$ , $I_{COM} = -32\text{ mA}$ ,	Switch ON, see <a href="#">Figure 17</a>	25°C	3 V		5	7	$\Omega$
				Full			8		
$I_{NC(OFF)}, I_{NO(OFF)}$	NC, NO OFF leakage current	$V_{NC} \text{ or } V_{NO} = 1\text{ V}$ , $V_{COM} = 3\text{ V}$ , or $V_{NC} \text{ or } V_{NO} = 3\text{ V}$ , $V_{COM} = 1\text{ V}$ , $V_{NC} \text{ or } V_{NO} = 0\text{ to }3.6\text{ V}$ , $V_{COM} = 3.6\text{ V to }0$ , or $V_{NC} \text{ or } V_{NO} = 3.6\text{ V to }0$ , $V_{COM} = 0\text{ to }3.6\text{ V}$ ,	Switch OFF, see <a href="#">Figure 18</a>	25°C	3.6 V	-0.1	0.05	0.1	$\mu\text{A}$
				Full		-0.2		0.2	
$I_{NC(OFF)}, I_{NO(OFF)}$	NC, NO OFF leakage current	$V_{NC} \text{ or } V_{NO} = 0\text{ to }3.6\text{ V}$ , $V_{COM} = 3.6\text{ V to }0$ , or $V_{NC} \text{ or } V_{NO} = 3.6\text{ V to }0$ , $V_{COM} = 0\text{ to }3.6\text{ V}$ ,	Switch OFF, see <a href="#">Figure 18</a>	25°C	0 V	-2	0.05	2	$\mu\text{A}$
				Full		-10		10	
$I_{COM(OFF)}$	COM OFF leakage current	$V_{COM} = 1\text{ V}$ , $V_{NC} \text{ or } V_{NO} = 3\text{ V}$ , or $V_{COM} = 3\text{ V}$ , $V_{NC} \text{ or } V_{NO} = 3\text{ V}$ ,	Switch OFF, see <a href="#">Figure 18</a>	25°C	3.6 V	-0.1	0.05	0.1	$\mu\text{A}$
				Full		-0.2		0.2	
$I_{COM(OFF)}$	COM OFF leakage current	$V_{COM} = 0\text{ to }3.6\text{ V}$ , $V_{NC} \text{ or } V_{NO} = 3.6\text{ V to }0$ , or $V_{COM} = 3.6\text{ V to }0$ , $V_{NC} \text{ or } V_{NO} = 0\text{ to }3.6\text{ V}$ ,	Switch OFF, see <a href="#">Figure 18</a>	25°C	0 V	-2	0.05	2	$\mu\text{A}$
				Full		-10		10	
$I_{NC(ON)}, I_{NO(ON)}$	NC, NO ON leakage current	$V_{NC} \text{ or } V_{NO} = 1\text{ V}$ , $V_{COM} = \text{Open}$ , or $V_{NC} \text{ or } V_{NO} = 3\text{ V}$ , $V_{COM} = \text{Open}$ ,	Switch ON, see <a href="#">Figure 19</a>	25°C	3.6 V	-0.1	0.05	0.1	$\mu\text{A}$
				Full		-0.2		0.2	
$I_{COM(ON)}$	COM ON leakage current	$V_{COM} = 1\text{ V}$ , $V_{NC} \text{ or } V_{NO} = \text{Open}$ , or $V_{COM} = 3\text{ V}$ , $V_{NC} \text{ or } V_{NO} = \text{Open}$ ,	Switch ON, see <a href="#">Figure 19</a>	25°C	3.6 V	-0.1	0.05	0.1	$\mu\text{A}$
				Full		-0.2		0.2	
$V_{IH}$	Input logic high			Full		2		$V_+$	V
$V_{IL}$	Input logic low			Full		0		0.8	V
$I_{IH}, I_{IL}$	Input leakage current	$V_i = V_+ \text{ or } 0$		25°C	3.6 V	-1	0.05	1	$\mu\text{A}$
				Full		-1		1	
$Q_C$	Charge injection	$V_{GEN} = 0$ , $R_{GEN} = 0$ ,	$C_L = 0.1\text{ nF}$ , see <a href="#">Figure 26</a>	25°C	3.3 V		2		pC
$C_{NC(OFF)}, C_{NO(OFF)}$	NC, NO OFF capacitance	$V_{NC} \text{ or } V_{NO} = V_+ \text{ or GND}$ ,	Switch OFF, see <a href="#">Figure 20</a>	25°C	3.3 V		4.5		pF
$C_{COM(OFF)}$	COM OFF capacitance	$V_{COM} = V_+ \text{ or GND}$ ,	Switch OFF, see <a href="#">Figure 20</a>	25°C	3.3 V		9		pF
$C_{NC(ON)}, C_{NO(ON)}$	NC, NO ON capacitance	$V_{NC} \text{ or } V_{NO} = V_+ \text{ or GND}$ ,	Switch ON, see <a href="#">Figure 20</a>	25°C	3.3 V		16		pF
$C_{COM(ON)}$	COM ON capacitance	$V_{COM} = V_+ \text{ or GND}$ ,	Switch ON, see <a href="#">Figure 20</a>	25°C	3.3 V		16		pF

(1) The algebraic convention is used in this data sheet; the most negative value is shown in the minimum column.

**Electrical Characteristics for 3.3-V Supply (continued)**
 $V_+ = 3\text{ V to }3.6\text{ V}$ ,  $T_A = -40^\circ\text{C to }85^\circ\text{C}$  (unless otherwise noted)<sup>(1)</sup>

PARAMETER		TEST CONDITIONS		$T_A$	$V_+$	MIN	TYP	MAX	UNIT
$C_I$	Digital input capacitance	$V_I = V_+$ or GND,	See <a href="#">Figure 20</a>	25°C	3.3 V		3		pF
BW	Bandwidth	$R_L = 50\ \Omega$ ,	Switch ON, see <a href="#">Figure 22</a>	25°C	3.3 V		300		MHz
$O_{ISO}$	OFF isolation	$R_L = 50\ \Omega$ , $f = 10\text{ MHz}$ ,	Switch OFF, see <a href="#">Figure 23</a>	25°C	3.3 V		-48		dB
$X_{TALK}$	Crosstalk	$R_L = 50\ \Omega$ , $f = 10\text{ MHz}$ ,	Switch ON, see <a href="#">Figure 24</a>	25°C	3.3 V		-48		dB
$X_{TALK(ADJ)}$	Crosstalk adjacent	$R_L = 50\ \Omega$ , $f = 10\text{ MHz}$ ,	Switch ON, see <a href="#">Figure 25</a>	25°C	3.3 V		-81		dB
THD	Total harmonic distortion	$R_L = 600\ \Omega$ , $C_L = 50\text{ pF}$ ,	$f = 20\text{ Hz to }20\text{ kHz}$ , see <a href="#">Figure 27</a>	25°C	3.3 V		0.21%		
$I_+$	Positive supply current	$V_I = V_+$ or GND,	Switch ON or OFF	25°C	3.6 V		2.5	7	$\mu\text{A}$
				Full				10	

**6.6 Electrical Characteristics for 2.5-V Supply**
 $V_+ = 2.3\text{ V to }2.7\text{ V}$ ,  $T_A = -40^\circ\text{C to }85^\circ\text{C}$  (unless otherwise noted)<sup>(1)</sup>

PARAMETER		TEST CONDITIONS		$T_A$	$V_+$	MIN	TYP	MAX	UNIT
$V_{COM}, V_{NC}, V_{NO}$	Analog signal range					0		$V_+$	V
$r_{on}$	ON-state resistance	$0 \leq (V_{NC} \text{ or } V_{NO}) \leq V_+$ , $I_{COM} = -24\text{ mA}$ ,	Switch ON, see <a href="#">Figure 17</a>	25°C	2.3 V		12	20	$\Omega$
				Full			22		
$\Delta r_{on}$	ON-state resistance match between channels	$V_{NC} \text{ or } V_{NO} = 1.6\text{ V}$ , $I_{COM} = -24\text{ mA}$ ,	Switch ON, see <a href="#">Figure 17</a>	25°C	2.3 V		0.3	1	$\Omega$
				Full			2		
$r_{on(flat)}$	ON-state resistance flatness	$0 \leq (V_{NC} \text{ or } V_{NO}) \leq V_+$ , $I_{COM} = -24\text{ mA}$ ,	Switch ON, see <a href="#">Figure 17</a>	25°C	2.3 V		14	18	$\Omega$
				Full			20		
$I_{NC(OFF)}, I_{NO(OFF)}$	NC, NO OFF leakage current	$V_{NC} \text{ or } V_{NO} = 0.5\text{ V}$ , $V_{COM} = 2.2\text{ V}$ , or $V_{NC} \text{ or } V_{NO} = 2.2\text{ V}$ , $V_{COM} = 0.5\text{ V}$ ,	Switch OFF, see <a href="#">Figure 18</a>	25°C	2.7 V	-0.1	0.05	0.1	$\mu\text{A}$
				Full			-0.2	0.2	
$I_{NC(OFF)}, I_{NO(OFF)}$	NC, NO OFF leakage current	$V_{NC} \text{ or } V_{NO} = 0 \text{ to } 3.6\text{ V}$ , $V_{COM} = 3.6\text{ V to } 0$ , or $V_{NC} \text{ or } V_{NO} = 3.6\text{ V to } 0$ , $V_{COM} = 0 \text{ to } 3.6\text{ V}$ ,	Switch OFF, see <a href="#">Figure 18</a>	25°C	0 V	-2	0.05	2	$\mu\text{A}$
				Full			-10	10	
$I_{COM(OFF)}$	COM OFF leakage current	$V_{COM} = 0.5\text{ V}$ , $V_{NC} \text{ or } V_{NO} = 2.2\text{ V}$ , or $V_{COM} = 2.2\text{ V}$ , $V_{NC} \text{ or } V_{NO} = 0.5\text{ V}$ ,	Switch OFF, see <a href="#">Figure 18</a>	25°C	2.7 V	-0.1	0.05	0.1	$\mu\text{A}$
				Full			-0.2	0.2	
$I_{COM(OFF)}$	COM OFF leakage current	$V_{COM} = 0 \text{ to } 3.6\text{ V}$ , $V_{NC} \text{ or } V_{NO} = 3.6\text{ V to } 0$ , or $V_{COM} = 3.6\text{ V to } 0$ , $V_{NC} \text{ or } V_{NO} = 0 \text{ to } 3.6\text{ V}$ ,	Switch OFF, see <a href="#">Figure 18</a>	25°C	0 V	-2	0.05	2	$\mu\text{A}$
				Full			-10	10	
$I_{NC(ON)}, I_{NO(ON)}$	NC, NO ON leakage current	$V_{NC} \text{ or } V_{NO} = 0.5\text{ V}$ , $V_{COM} = \text{Open}$ , or $V_{NC} \text{ or } V_{NO} = 2.2\text{ V}$ , $V_{COM} = \text{Open}$ ,	Switch ON, see <a href="#">Figure 19</a>	25°C	2.7 V	-0.1	0.05	0.1	$\mu\text{A}$
				Full			-0.2	0.2	
$I_{COM(ON)}$	COM ON leakage current	$V_{COM} = 0.5\text{ V}$ , $V_{NC} \text{ or } V_{NO} = \text{Open}$ , or $V_{COM} = 2.2\text{ V}$ , $V_{NC} \text{ or } V_{NO} = \text{Open}$ ,	Switch ON, see <a href="#">Figure 19</a>	25°C	2.7 V	-0.1	0.05	0.1	$\mu\text{A}$
				Full			-0.2	0.2	
$V_{IH}$	Input logic high			Full		1.7		$V_+$	V
$V_{IL}$	Input logic low			Full		0		0.7	V

(1) The algebraic convention is used in this data sheet; the most negative value is shown in the minimum column.

## Electrical Characteristics for 2.5-V Supply (continued)

 $V_+ = 2.3 \text{ V to } 2.7 \text{ V}$ ,  $T_A = -40^\circ\text{C to } 85^\circ\text{C}$  (unless otherwise noted)<sup>(1)</sup>

PARAMETER	TEST CONDITIONS	$T_A$	$V_+$	MIN	TYP	MAX	UNIT	
$I_{IH}$ , $I_{IL}$	Input leakage current	$V_I = V_+$ or 0	25°C	2.7 V	-0.1	0.05	0.1	$\mu\text{A}$
			Full		-1	1		
$Q_C$	Charge injection	$V_{GEN} = 0$ , $R_{GEN} = 0$ ,	$C_L = 0.1 \text{ nF}$ , see Figure 26	25°C	2.5 V	1	pC	
$C_{NC(OFF)}$ , $C_{NO(OFF)}$	NC, NO OFF capacitance	$V_{NC}$ or $V_{NO} = V_+$ or GND,	Switch OFF, see Figure 20	25°C	2.5 V	3	pF	
$C_{COM(OFF)}$	COM OFF capacitance	$V_{COM} = V_+$ or GND,	Switch OFF, see Figure 20	25°C	2.5 V	9	pF	
$C_{NC(ON)}$ , $C_{NO(ON)}$	NC, NO ON capacitance	$V_{NC}$ or $V_{NO} = V_+$ or GND,	Switch ON, see Figure 20	25°C	2.5 V	16	pF	
$C_{COM(ON)}$	COM ON capacitance	$V_{COM} = V_+$ or GND,	Switch ON, see Figure 20	25°C	2.5 V	16	pF	
$C_I$	Digital input capacitance	$V_I = V_+$ or GND,	See Figure 20	25°C	2.5 V	3	pF	
BW	Bandwidth	$R_L = 50 \Omega$ ,	Switch ON, see Figure 22	25°C	2.5 V	300	MHz	
$O_{ISO}$	OFF isolation	$R_L = 50 \Omega$ , $f = 10 \text{ MHz}$ ,	Switch OFF, see Figure 23	25°C	2.5 V	-48	dB	
$X_{TALK}$	Crosstalk	$R_L = 50 \Omega$ , $f = 10 \text{ MHz}$ ,	Switch ON, see Figure 24	25°C	2.5 V	-48	dB	
$X_{TALK(ADJ)}$	Crosstalk adjacent	$R_L = 50 \Omega$ , $f = 10 \text{ MHz}$ ,	Switch ON, see Figure 25	25°C	3.3 V	-81	dB	
THD	Total harmonic distortion	$R_L = 600 \Omega$ , $C_L = 50 \text{ pF}$ ,	$f = 20 \text{ Hz to } 20 \text{ kHz}$ , see Figure 27	25°C	2.5 V	0.33%		
$I_+$	Positive supply current	$V_I = V_+$ or GND,	Switch ON or OFF	25°C	2.7 V	2.5	7	$\mu\text{A}$
				Full		10		

## 6.7 Electrical Characteristics for 2.1-V Supply

 $V_+ = 2.00 \text{ V to } 2.20 \text{ V}$ ,  $T_A = -40^\circ\text{C to } 85^\circ\text{C}$  (unless otherwise noted)<sup>(1)</sup>

PARAMETER	TEST CONDITIONS	$T_A$	$V_+$	MIN	TYP	MAX	UNIT
$V_{IH}$	Input logic high	Full		1.2		4.3	V
$V_{IL}$	Input logic low	Full		0		0.5	V

(1) The algebraic convention is used in this data sheet; the most negative value is shown in the minimum column.

## 6.8 Electrical Characteristics for 1.8-V Supply

 $V_+ = 1.65 \text{ V to } 1.95 \text{ V}$ ,  $T_A = -40^\circ\text{C to } 85^\circ\text{C}$  (unless otherwise noted)<sup>(1)</sup>

PARAMETER	TEST CONDITIONS	$T_A$	$V_+$	MIN	TYP	MAX	UNIT	
$V_{COM}$ , $V_{NC}$ , $V_{NO}$	Analog signal range			0		$V_+$	V	
$r_{on}$	ON-state resistance	$0 \leq (V_{NC} \text{ or } V_{NO}) \leq V_+$ , $I_{COM} = -32 \text{ mA}$ ,	Switch ON, see Figure 17	25°C	1.65 V	5.5	17	$\Omega$
				Full		32		
$\Delta r_{on}$	ON-state resistance match between channels	$V_{NC}$ or $V_{NO} = 1.5 \text{ V}$ , $I_{COM} = -32 \text{ mA}$ ,	Switch ON, see Figure 17	25°C	1.65 V	0.3	1	$\Omega$
				Full		1.2		
$r_{on(Flat)}$	ON-state resistance flatness	$0 \leq (V_{NC} \text{ or } V_{NO}) \leq V_+$ , $I_{COM} = -32 \text{ mA}$ ,	Switch ON, see Figure 17	25°C	1.65 V	2.7	5.5	$\Omega$
				Full		7.3		

(1) The algebraic convention is used in this data sheet; the most negative value is shown in the minimum column.

**Electrical Characteristics for 1.8-V Supply (continued)**
 $V_+ = 1.65\text{ V to }1.95\text{ V}$ ,  $T_A = -40^\circ\text{C to }85^\circ\text{C}$  (unless otherwise noted)<sup>(1)</sup>

PARAMETER	TEST CONDITIONS	$T_A$	$V_+$	MIN	TYP	MAX	UNIT
$I_{NC(OFF)}$ , $I_{NO(OFF)}$	$V_{NC}$ or $V_{NO} = 0.3\text{ V}$ , $V_{COM} = 1.65\text{ V}$ , or $V_{NC}$ or $V_{NO} = 1.65\text{ V}$ , $V_{COM} = 0.3\text{ V}$ , Switch OFF, see <a href="#">Figure 18</a>	25°C	1.95 V	-0.25	0.03	0.25	$\mu\text{A}$
		Full		-4.5		4.5	
	$V_{NC}$ or $V_{NO} = 1.95\text{ V to }0\text{ V}$ , $V_{COM} = 0\text{ V to }1.95\text{ V}$ , or $V_{NC}$ or $V_{NO} = 0\text{ V to }1.95\text{ V}$ , $V_{COM} = 1.95\text{ V to }0\text{ V}$ , Switch OFF, see <a href="#">Figure 18</a>	25°C	0 V	-0.4	0.01	0.4	
		Full		-6.5		6.5	
$I_{COM(OFF)}$	$V_{COM} = 1.65\text{ V}$ , $V_{NC}$ or $V_{NO} = 0.3\text{ V}$ , or $V_{COM} = 0.3\text{ V}$ , $V_{NC}$ or $V_{NO} = 1.65\text{ V}$ , Switch OFF, see <a href="#">Figure 18</a>	25°C	1.95 V	-0.4	0.02	0.4	$\mu\text{A}$
		Full		-0.9		0.9	
	$V_{COM} = 0\text{ V to }1.95\text{ V}$ , $V_{NC}$ or $V_{NO} = 1.95\text{ V to }0\text{ V}$ , or $V_{COM} = 1.95\text{ V to }0$ , $V_{NC}$ or $V_{NO} = 0\text{ to }1.95\text{ V}$ , Switch OFF, see <a href="#">Figure 18</a>	25°C	0 V	-0.4	0.02	0.4	
		Full		-4.5		4.5	
$I_{NC(ON)}$ , $I_{NO(ON)}$	$V_{NC}$ or $V_{NO} = 0.3\text{ V}$ , $V_{COM} = \text{Open}$ , or $V_{NC}$ or $V_{NO} = 1.65\text{ V}$ , $V_{COM} = \text{Open}$ , Switch ON, see <a href="#">Figure 19</a>	25°C	1.95 V	-2	0.02	2	$\mu\text{A}$
		Full		-2	0.02	2	
$I_{COM(ON)}$	$V_{COM} = 0.3\text{ V}$ , $V_{NC}$ or $V_{NO} = \text{Open}$ , or $V_{COM} = 1.65\text{ V}$ , $V_{NC}$ or $V_{NO} = \text{Open}$ , Switch ON, see <a href="#">Figure 19</a>	25°C	1.95 V	-4.5		4.5	$\mu\text{A}$
		Full					
$V_{IH}$	Input logic high	Full	1.95 V	1		3.6	V
$V_{IL}$	Input logic low	Full	1.95 V	0		0.4	V
$I_{IH}$ , $I_{IL}$	Input leakage current	25°C	1.95 V	-0.1	0.01	0.1	$\mu\text{A}$
		Full		-2.1		2.1	

**6.9 Switching Characteristics for 3.3-V Supply**

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	$T_A$	$V_+$	MIN	TYP	MAX	UNIT
$t_{ON}$	$V_{COM} = 2\text{ V}$ , $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ , see <a href="#">Figure 21</a>	25°C	3.3 V	2.5	3.5	8	ns
		Full	3 V to 3.6 V	2.5		9	
$t_{OFF}$	$V_{COM} = 2\text{ V}$ , $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ , see <a href="#">Figure 21</a>	25°C	3.3 V	0.5	2	6.5	ns
		Full	3 V to 3.6 V	0.5		7	

**6.10 Switching Characteristics for 2.5-V Supply**

over operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	$T_A$	$V_+$	MIN	TYP	MAX	UNIT
$t_{ON}$	$V_{COM} = 1.5\text{ V}$ , $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ , see <a href="#">Figure 21</a>	25°C	2.5 V	2.5	5	9.5	ns
		Full	2.3 V to 2.7 V	2.5		10.5	
$t_{OFF}$	$V_{COM} = 1.5\text{ V}$ , $R_L = 300\ \Omega$ , $C_L = 35\text{ pF}$ , see <a href="#">Figure 21</a>	25°C	2.5 V	0.5	3	7.5	ns
		Full	2.3 V to 2.7 V	0.5		9	



## 6.11 Switching Characteristics for 1.8-V Supply

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		T <sub>A</sub>	V <sub>+</sub>	MIN	TYP	MAX	UNIT
t <sub>ON</sub>	Turnon time	V <sub>COM</sub> = V <sub>+</sub> , R <sub>L</sub> = 50 Ω,	C <sub>L</sub> = 35 pF, see <a href="#">Figure 21</a>	25°C	1.8 V		14.1	49.3	ns
				Full	1.65 V to 1.95 V		49.3	56.7	
t <sub>OFF</sub>	Turnoff time	V <sub>COM</sub> = V <sub>+</sub> , R <sub>L</sub> = 50 Ω,	C <sub>L</sub> = 35 pF, see <a href="#">Figure 21</a>	25°C	1.8 V		16.1	26.5	ns
				Full	1.65 V to 1.95 V			31.2	
t <sub>BBM</sub>	Break-before- make time	V <sub>NC</sub> = V <sub>NO</sub> = V <sub>+</sub> /2, R <sub>L</sub> = 50 Ω,	C <sub>L</sub> = 35 pF, see <a href="#">Figure 21</a>	25°C	1.8 V	5.3	18.4	58	ns
				Full	1.65 V to 1.95 V			58	

### 6.12 Typical Characteristics

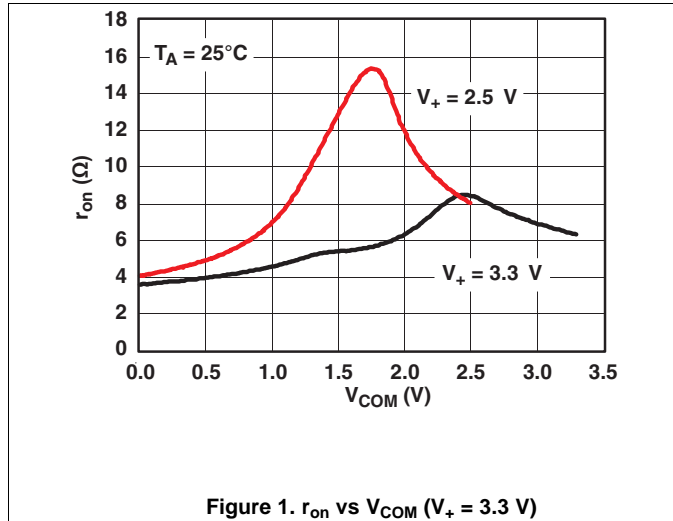


Figure 1.  $r_{on}$  vs  $V_{COM}$  ( $V_+ = 3.3$  V)

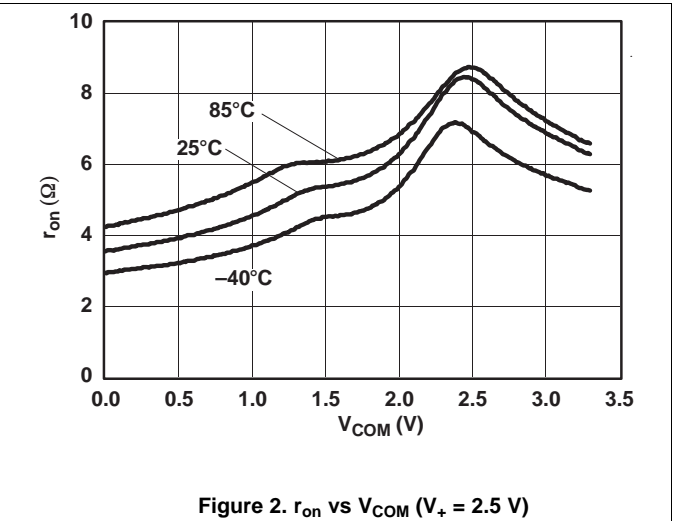


Figure 2.  $r_{on}$  vs  $V_{COM}$  ( $V_+ = 2.5$  V)

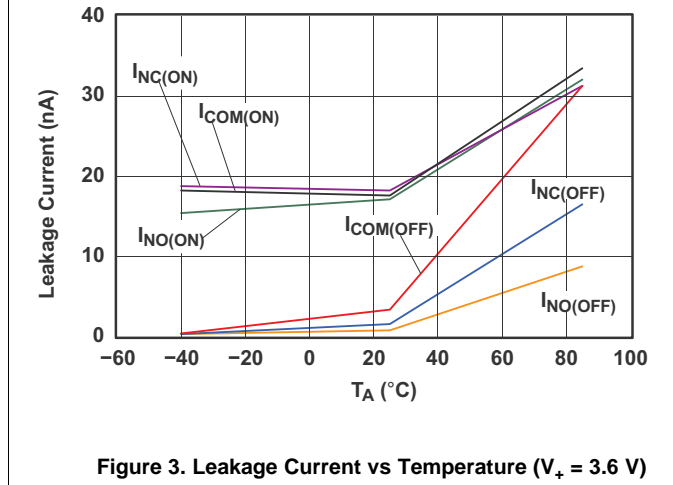


Figure 3. Leakage Current vs Temperature ( $V_+ = 3.6$  V)

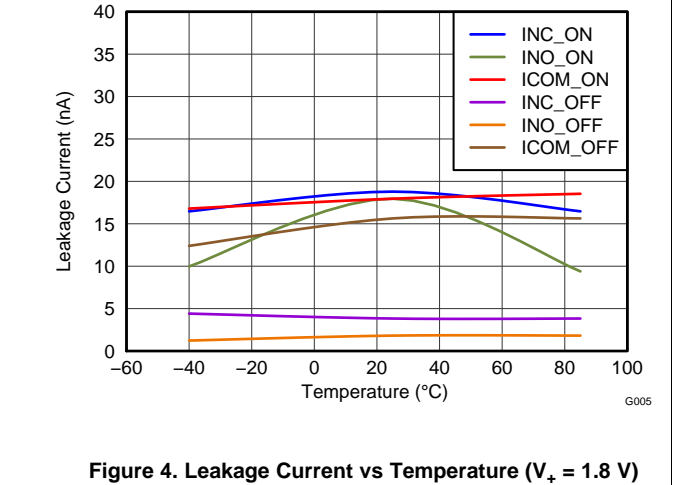


Figure 4. Leakage Current vs Temperature ( $V_+ = 1.8$  V)

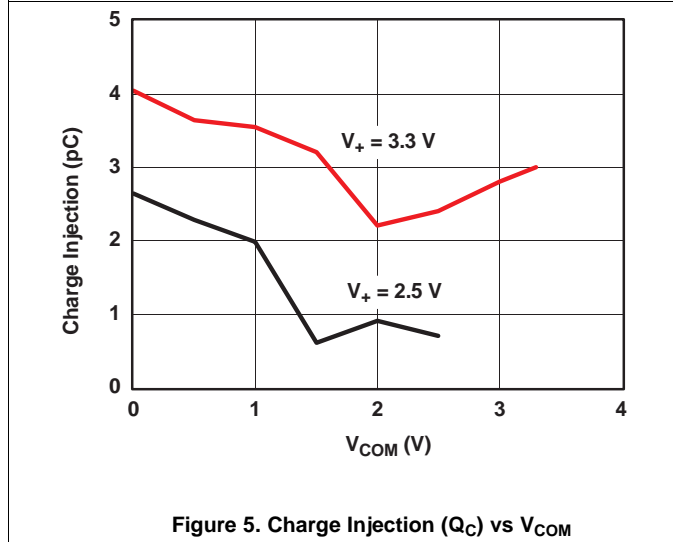


Figure 5. Charge Injection ( $Q_C$ ) vs  $V_{COM}$

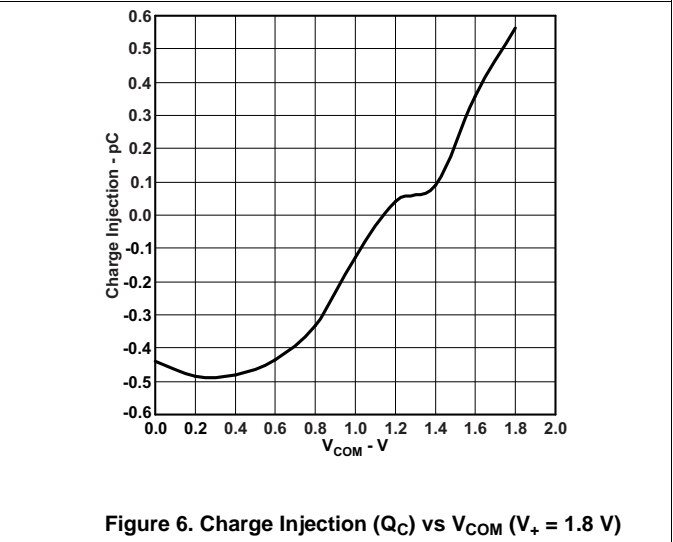


Figure 6. Charge Injection ( $Q_C$ ) vs  $V_{COM}$  ( $V_+ = 1.8$  V)

Typical Characteristics (continued)

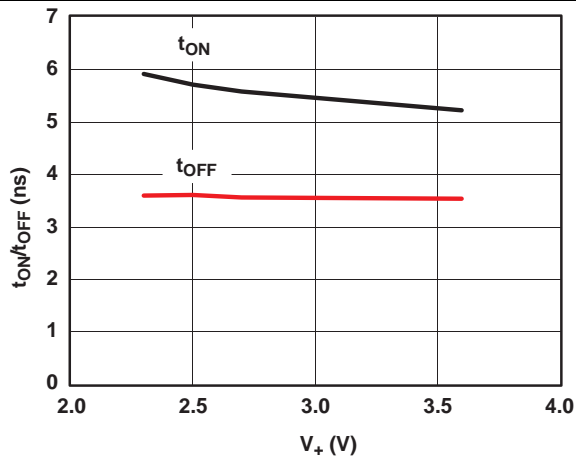


Figure 7. t<sub>ON</sub> and t<sub>OFF</sub> vs Supply Voltage

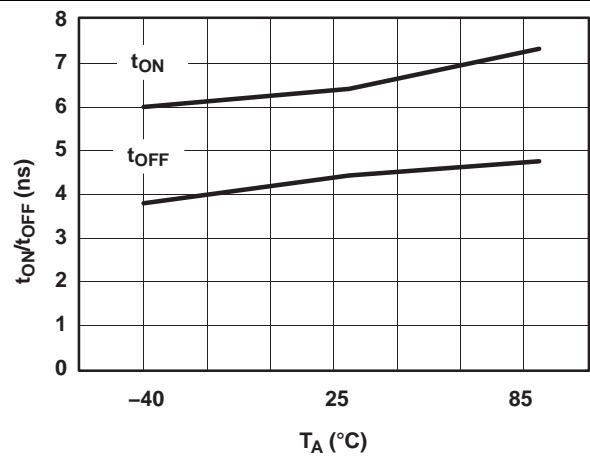


Figure 8. t<sub>ON</sub> and t<sub>OFF</sub> vs Temperature (V<sub>+</sub> = 3.3 V)

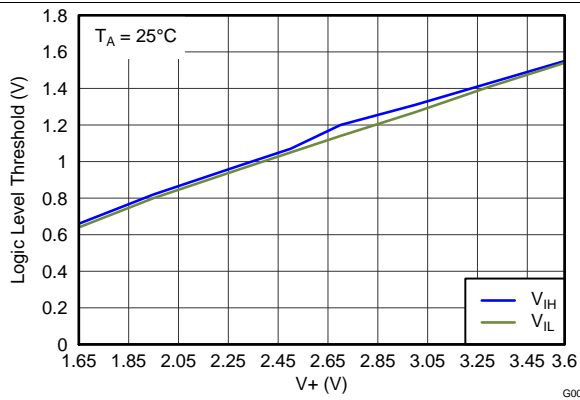


Figure 9. Logic-Level Threshold vs V<sub>+</sub>

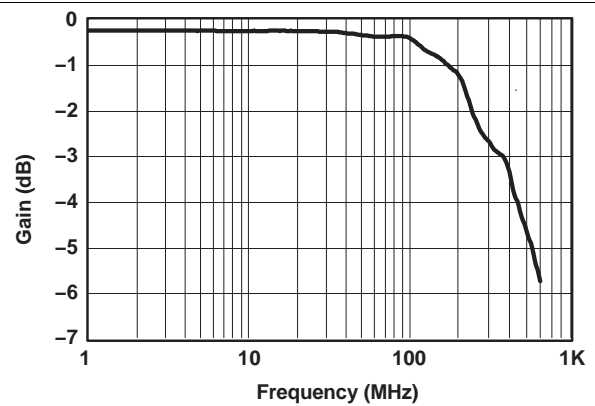


Figure 10. Gain vs Frequency Bandwidth (V<sub>+</sub> = 3.3 V)

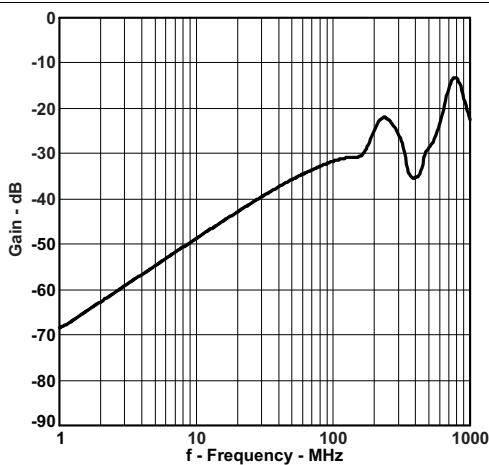


Figure 11. OFF Isolation vs Frequency (V<sub>+</sub> = 1.8 V)

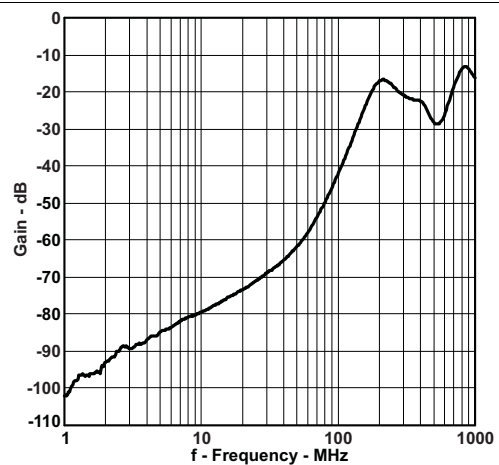
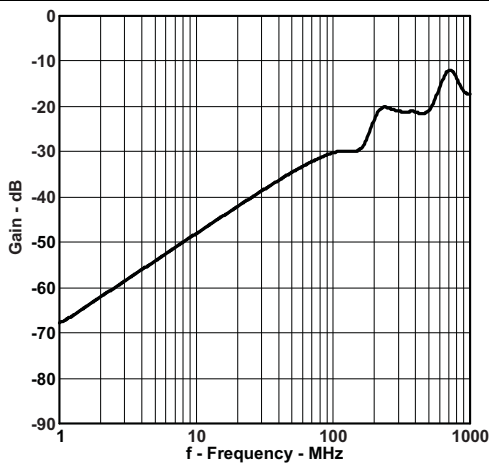
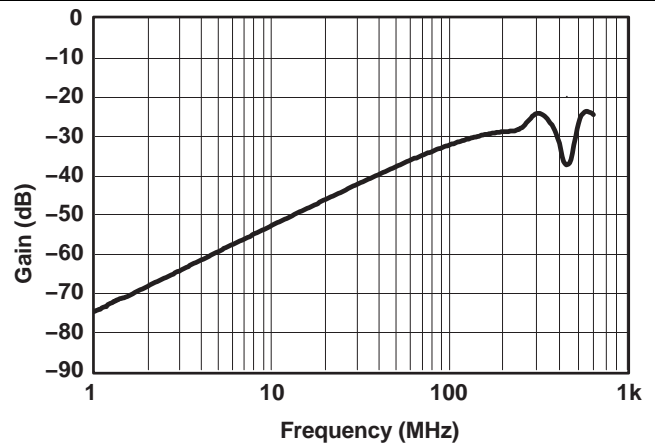


Figure 12. Crosstalk Adjacent vs Frequency (V<sub>+</sub> = 1.8 V)

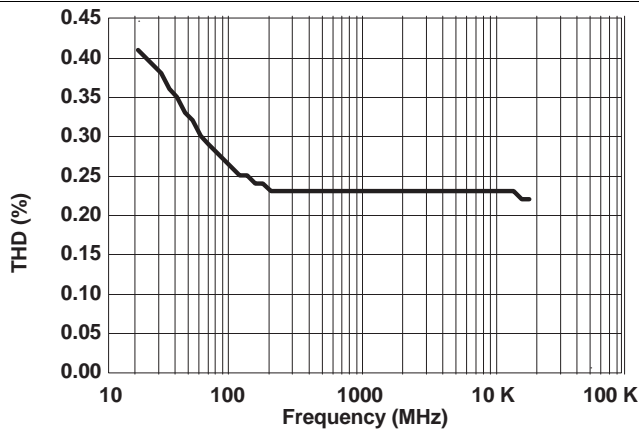
**Typical Characteristics (continued)**



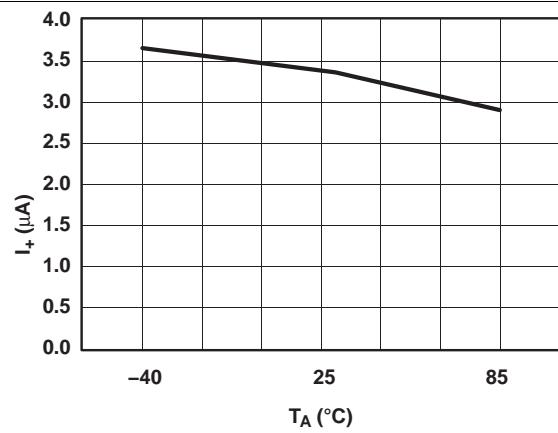
**Figure 13. Crosstalk vs Frequency ( $V_+ = 1.8\text{ V}$ )**



**Figure 14. OFF Isolation vs Frequency ( $V_+ = 3.3\text{ V}$ )**



**Figure 15. Total Harmonic Distortion vs Frequency**



**Figure 16. Power-Supply Current vs Temperature ( $V_+ = 3.3\text{ V}$ )**

## 7 Parameter Measurement Information

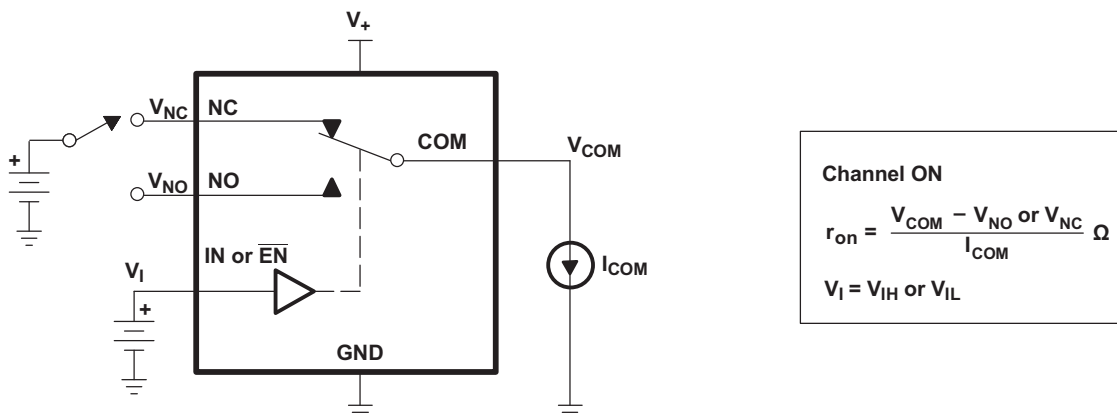


Figure 17. ON-State Resistance ( $r_{on}$ )

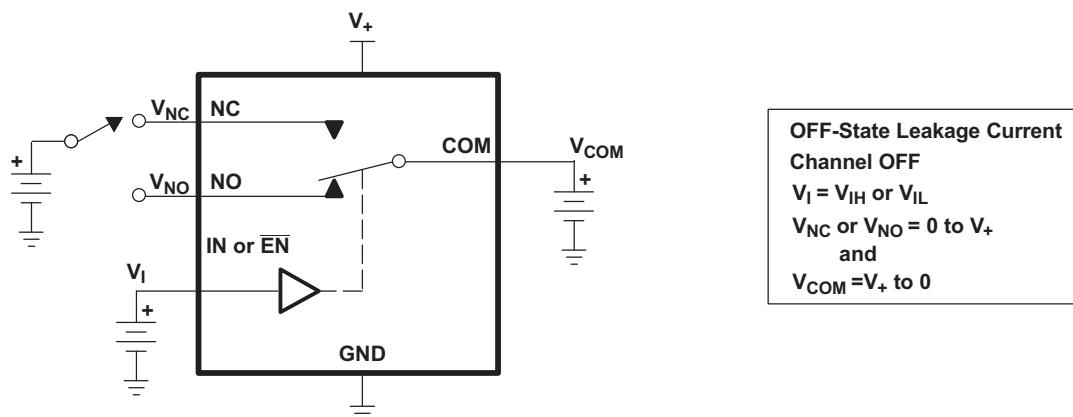


Figure 18. OFF-State Leakage Current ( $I_{COM(OFF)}$ ,  $I_{NC(OFF)}$ ,  $I_{NO(OFF)}$ )

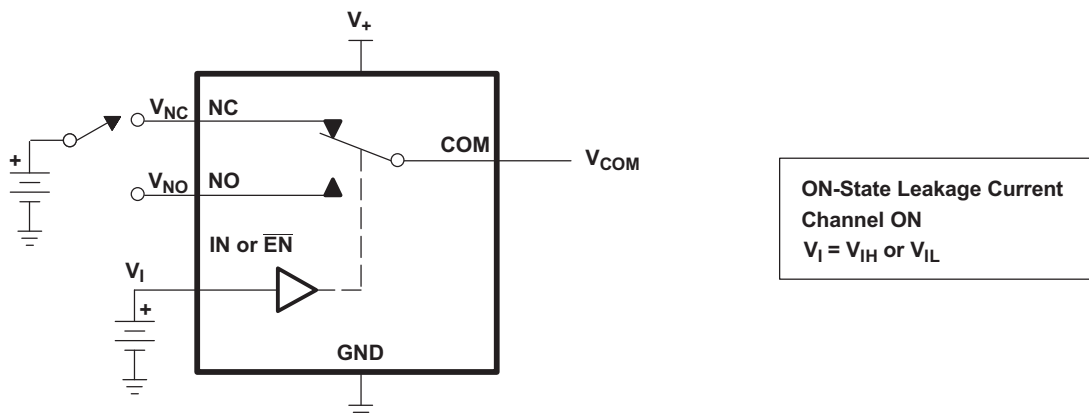


Figure 19. ON-State Leakage Current ( $I_{COM(ON)}$ ,  $I_{NC(ON)}$ )

Parameter Measurement Information (continued)

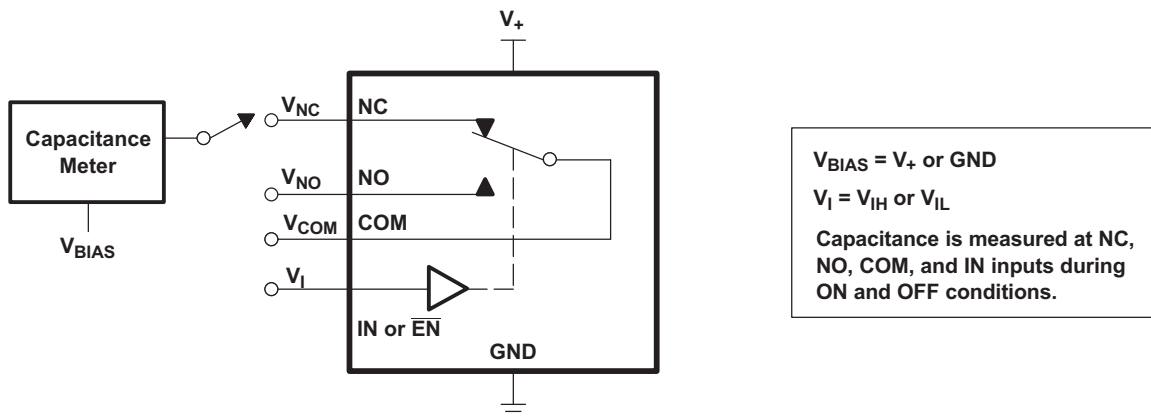
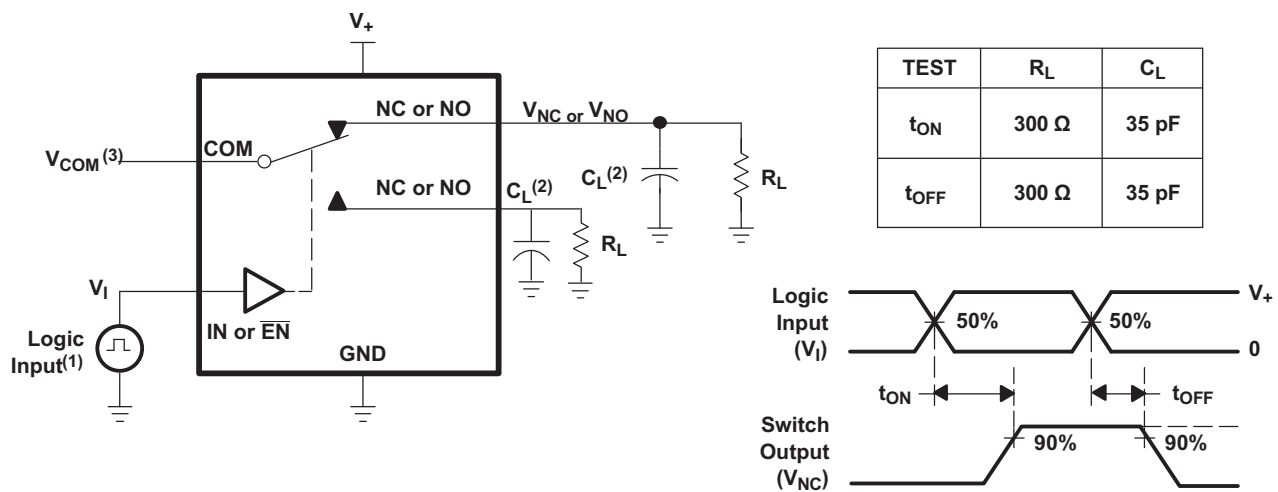


Figure 20. Capacitance ( $C_I$ ,  $C_{COM(OFF)}$ ,  $C_{COM(ON)}$ ,  $C_{NC(OFF)}$ ,  $C_{NC(ON)}$ )



- (1) All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O = 50 \Omega$ ,  $t_r < 5$  ns,  $t_f < 5$  ns.
- (2)  $C_L$  includes probe and jig capacitance.
- (3) See Electrical Characteristics for  $V_{COM}$ .

Figure 21. Turnon ( $t_{ON}$ ) and Turnoff Time ( $t_{OFF}$ )

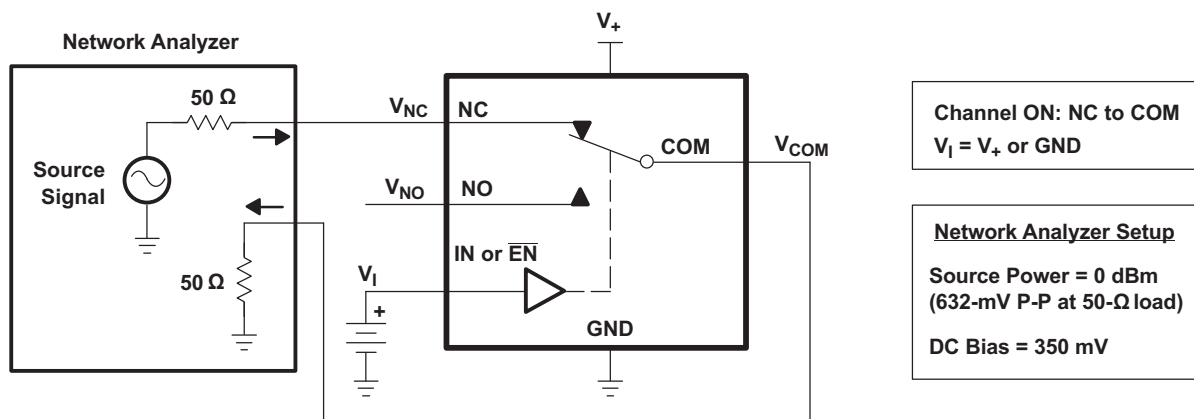


Figure 22. Bandwidth (BW)

Parameter Measurement Information (continued)

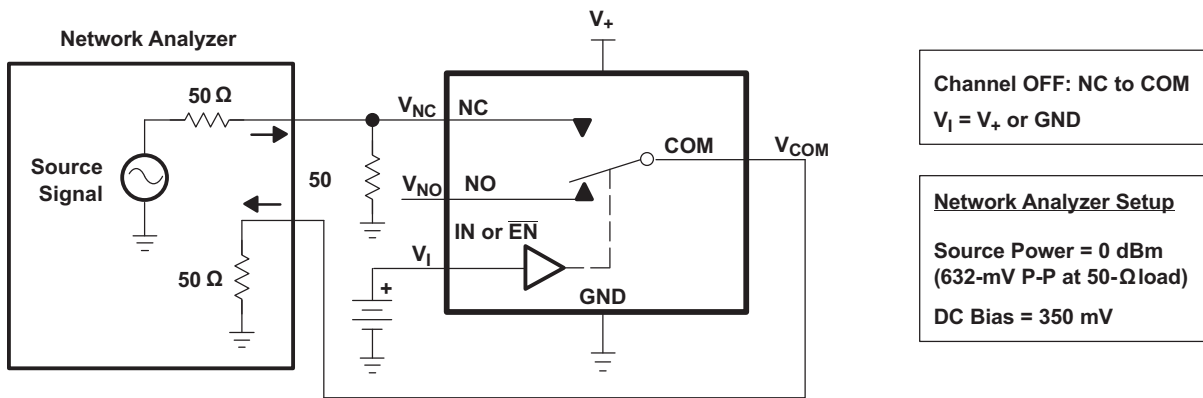


Figure 23. OFF Isolation ( $O_{ISO}$ )

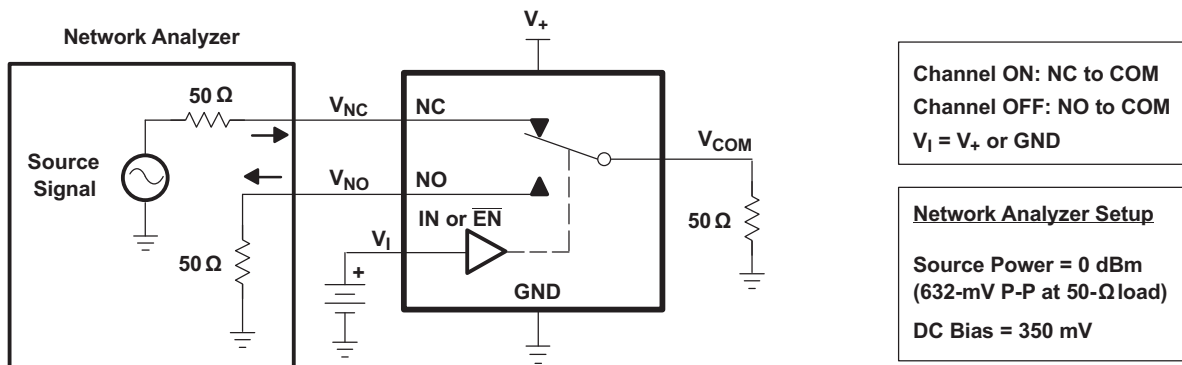


Figure 24. Crosstalk ( $X_{TALK}$ )

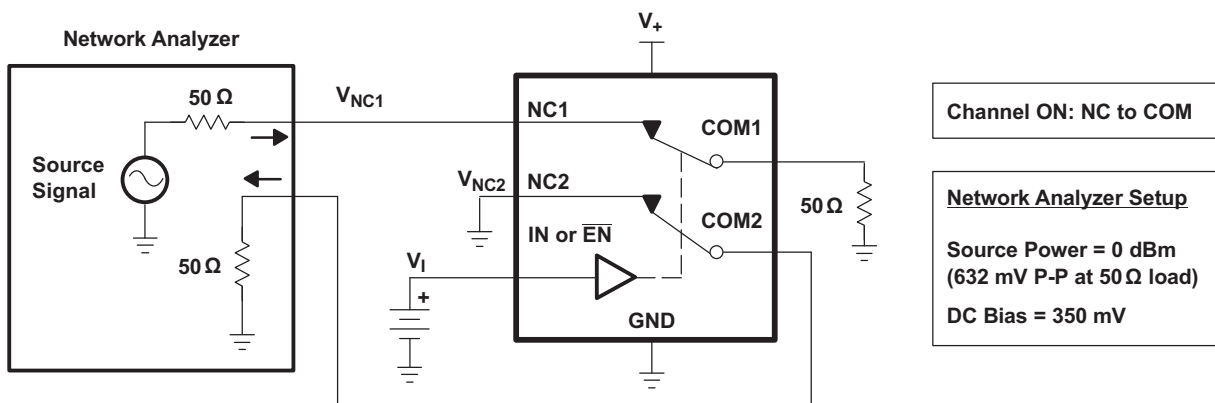
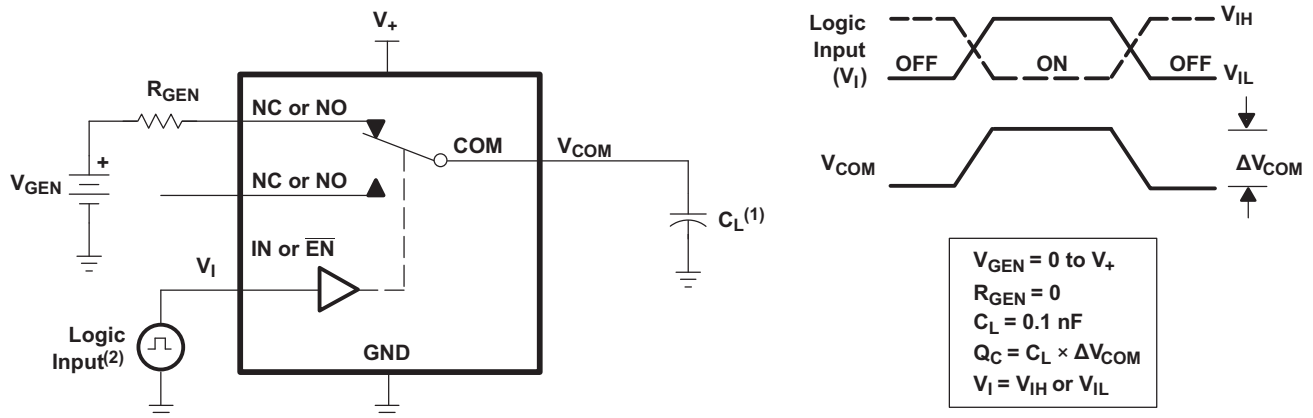


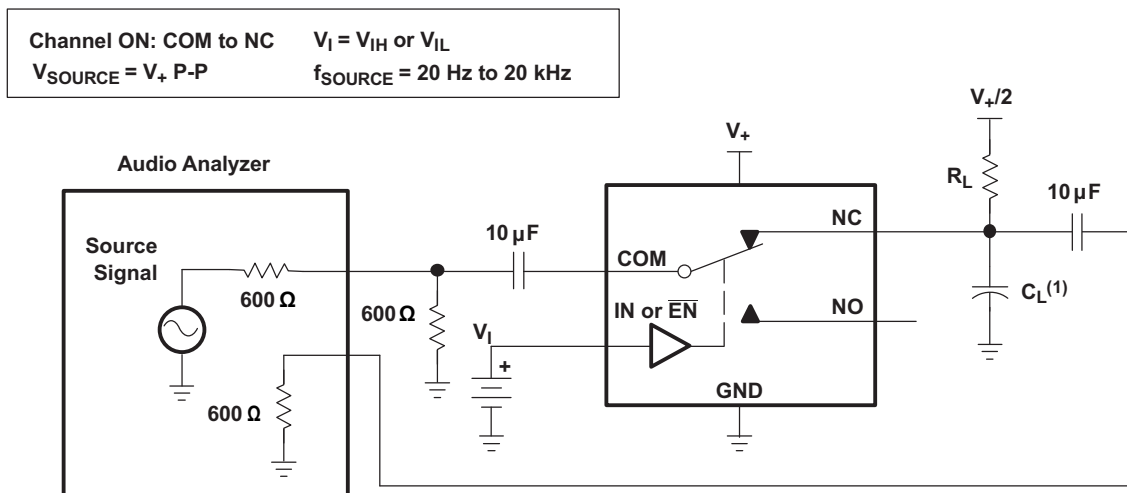
Figure 25. Crosstalk Adjacent

Parameter Measurement Information (continued)



- (1)  $C_L$  includes probe and jig capacitance.
- (2) All input pulses are supplied by generators having the following characteristics:  $PRR \leq 10 \text{ MHz}$ ,  $Z_O = 50 \Omega$ ,  $t_r < 5 \text{ ns}$ ,  $t_f < 5 \text{ ns}$ .

Figure 26. Charge Injection ( $Q_C$ )



- (1)  $C_L$  includes probe and jig capacitance.

Figure 27. Total Harmonic Distortion (THD)



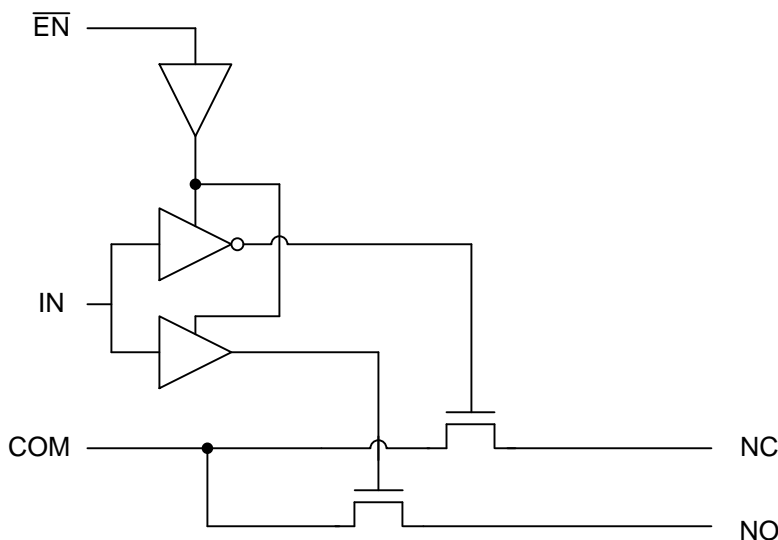
## 8 Detailed Description

### 8.1 Overview

The TS3A5018 is a quad single-pole-double-throw (SPDT) solid-state analog switch. The TS3A5018, like all analog switches, is bidirectional. When powered on, each COM pin is connected to its respective NC pin. For this device, NC stands for *normally closed* and NO stands for *normally open*. The switch is enabled when  $\overline{EN}$  is low. If IN is also low, COM is connected to NC. If IN is high, COM is connected to NO.

The TS3A5018 is a break-before-make switch. This means that during switching, a connection is broken before a new connection is established. The NC and NO pins are never connected to each other.

### 8.2 Functional Block Diagram (Each Switch)



### 8.3 Feature Description

The low ON-state resistance, ON-state resistance matching, and charge injection in the TS3A5018 make this switch an excellent choice for analog signals that require minimal distortion. In addition, the low THD allows audio signals to be preserved more clearly as they pass through the device.

The 1.8-V to 3.6-V operation allows compatibility with more logic levels, and the bidirectional I/Os can pass analog signals from 0 V to  $V_+$  with low distortion.

### 8.4 Device Functional Modes

**Table 1. Function Table**

$\overline{EN}$	IN	NO TO COM, COM TO NO	NC TO COM, COM TO NC
L	L	OFF	ON
L	H	ON	OFF
H	X	OFF	OFF

## 9 Application and Implementation

### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### 9.1 Application Information

The TS3A5018 can be used in a variety of customer systems. The TS3A5018 can be used anywhere multiple analog or digital signals must be selected to pass across a single line.

### 9.2 Typical Application

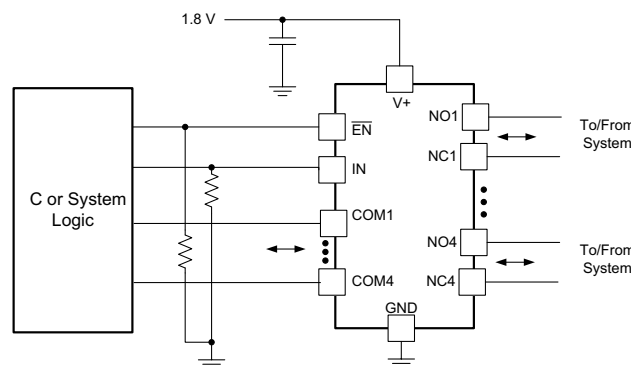


Figure 28. System Schematic for TS3A5018

#### 9.2.1 Design Requirements

In this particular application,  $V_+$  was 1.8 V, although  $V_+$  is allowed to be any voltage specified in [Recommended Operating Conditions](#). A decoupling capacitor is recommended on the  $V_+$  pin. See [Power Supply Recommendations](#) for more details.

#### 9.2.2 Detailed Design Procedure

In this application,  $\overline{EN}$  and IN are, by default, pulled low to GND. Choose these resistor sizes based on the current driving strength of the GPIO, the desired power consumption, and the switching frequency (if applicable). If the GPIO is open-drain, use pullup resistors instead.

#### 9.2.3 Application Curve

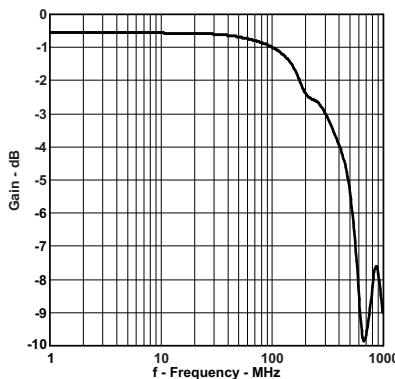


Figure 29. Gain vs Frequency Bandwidth ( $V_+ = 1.8 V$ )

## 10 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the [Recommended Operating Conditions](#).

Each  $V_{CC}$  terminal should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, a 0.1- $\mu\text{F}$  bypass capacitor is recommended. If there are multiple pins labeled  $V_{CC}$ , then a 0.01- $\mu\text{F}$  or 0.022- $\mu\text{F}$  capacitor is recommended for each  $V_{CC}$  because the  $V_{CC}$  pins will be tied together internally. For devices with dual supply pins operating at different voltages, for example  $V_{CC}$  and  $V_{DD}$ , a 0.1- $\mu\text{F}$  bypass capacitor is recommended for each supply pin. It is acceptable to parallel multiple bypass capacitors to reject different frequencies of noise. 0.1- $\mu\text{F}$  and 1- $\mu\text{F}$  capacitors are commonly used in parallel. The bypass capacitor should be installed as close to the power terminal as possible for best results.

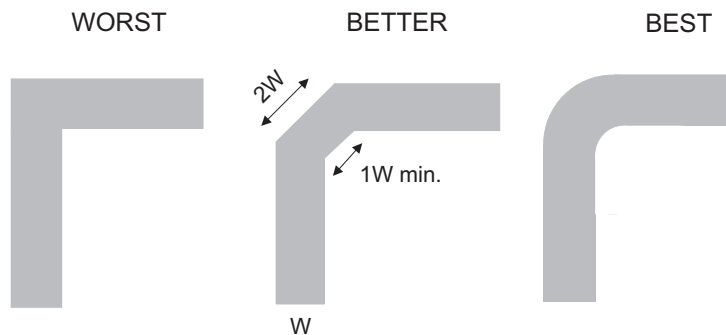
## 11 Layout

### 11.1 Layout Guidelines

Reflections and matching are closely related to loop antenna theory, but different enough to warrant their own discussion. When a PCB trace turns a corner at a 90° angle, a reflection can occur. This is primarily due to the change of width of the trace. At the apex of the turn, the trace width is increased to 1.414 times its width. This upsets the transmission line characteristics, especially the distributed capacitance and self-inductance of the trace — resulting in the reflection. It is a given that not all PCB traces can be straight, and so they will have to turn corners. [Figure 30](#) shows progressively better techniques of rounding corners. Only the last example maintains constant trace width and minimizes reflections.

Unused switch I/Os, such as NO, NC, and COM, can be left floating or tied to GND. However, the IN and  $\overline{\text{EN}}$  pins must be driven high or low. Due to partial transistor turnon when control inputs are at threshold levels, floating control inputs can cause increased  $I_{CC}$  or unknown switch selection states.

### 11.2 Layout Example



**Figure 30. Trace Example**

## 12 デバイスおよびドキュメントのサポート

### 12.1 デバイス・サポート

#### 12.1.1 デバイスの項目表記

表 2. パラメータの説明

記号	説明
$V_{COM}$	COM電圧
$V_{NC}$	NC電圧
$V_{NO}$	NO電圧
$r_{on}$	チャンネルがオンのときのCOMとNCポート間、またはCOMとNOポート間の抵抗
$\Delta r_{on}$	特定デバイスでのチャンネル間の $r_{on}$ の差
$r_{on(flat)}$	規定の条件の範囲における、チャンネルの $r_{on}$ の最大値と最小値との差
$I_{NC(OFF)}$	対応チャンネル(NCからCOM)がオフ状態のとき、NCポートで測定されるリーク電流
$I_{NC(ON)}$	対応チャンネル(NCからCOM)がオン状態、出力(COM)がオープンのとき、NCポートで測定されるリーク電流
$I_{NO(OFF)}$	対応チャンネル(NOからCOM)がオフ状態のとき、NOポートで測定されるリーク電流
$I_{NO(ON)}$	対応チャンネル(NOからCOM)がオン状態、出力(COM)がオープンのとき、NOポートで測定されるリーク電流
$I_{COM(OFF)}$	対応チャンネル(COMからNCまたはNO)がオフ状態のとき、COMポートで測定されるリーク電流
$I_{COM(ON)}$	対応チャンネル(COMからNCまたはNO)がオン状態、出力(NCまたはNO)がオープン/のとき、COMポートで測定されるリーク電流
$V_{IH}$	制御入力(IN, $\overline{EN}$ )の論理HIGHの最小入力電圧
$V_{IL}$	制御入力(IN, $\overline{EN}$ )の論理LOWの最大入力電圧
$V_I$	制御入力(IN, $\overline{EN}$ )の電圧
$I_{IH}, I_{IL}$	制御入力(IN, $\overline{EN}$ )で測定されるリーク電流
$t_{ON}$	スイッチのターンオン時間。このパラメータは、規定された条件の範囲で、スイッチがオンになるときのデジタル制御(IN)信号とアナログ出力(NCまたはNO)信号との間の伝搬遅延により測定されます。
$t_{OFF}$	スイッチのターンオフ時間。このパラメータは、規定された条件の範囲で、スイッチがオフになるときのデジタル制御(IN)信号とアナログ出力(NCまたはNO)信号との間の伝搬遅延により測定されます。
$Q_C$	電荷注入は、制御(IN)入力からアナログ(NCまたはNO)出力への、望ましくない信号のカップリングの測定値です。この値はクーロン(C)単位で、制御入力のスイッチングによって誘導される合計電荷により測定されます。電荷注入 $Q_C = C_L \times \Delta V_{COM}$ で、 $C_L$ は負荷容量、 $\Delta V_{COM}$ はアナログ出力電圧の変化です。
$C_{NC(OFF)}$	対応チャンネル(NCからCOM)がオフのときのNCポートの容量
$C_{NC(ON)}$	対応チャンネル(NCからCOM)がオンのときのNCポートの容量
$C_{NO(OFF)}$	対応チャンネル(NOからCOM)がオフのときのNCポートの容量
$C_{NO(ON)}$	対応チャンネル(NOからCOM)がオンのときのNCポートの容量
$C_{COM(OFF)}$	対応チャンネル(COMからNC)がオフのときのCOMポートの容量
$C_{COM(ON)}$	対応チャンネル(COMからNC)がオンのときのCOMポートの容量
$C_I$	制御入力(IN, $\overline{EN}$ )の容量
$O_{ISO}$	スイッチのオフ絶縁は、オフ状態のスイッチのインピーダンス測定値です。これは、対応チャンネル(NCからCOM)がオフ状態のとき、特定の周波数についてdB単位で測定されます。
$X_{TALK}$	クロストークは、オンのチャンネルからオフのチャンネル(NC1からNO1)への、望ましくない信号カップリングの測定値です。隣接クロストークは、オンのチャンネルから隣接するオンのチャンネル(NC1からNC2)への、望ましくない信号カップリングの測定値です。この値は特定の周波数において、dB単位で測定されます。
BW	スイッチの帯域幅。オン状態のチャンネルのゲインがDCゲインより-3dB低くなる周波数です。
THD	全高調波歪は、アナログ・スイッチにより発生する信号の歪みです。この値は、2次、3次、およびさらに高次の高調波の二乗平均(RMS)値と、基本波の絶対振幅との比として定義されます。
$I_+$	制御(IN)ピンが $V_+$ またはGNDであるときの静的消費電流

### 12.2 ドキュメントのサポート

#### 12.2.1 関連資料

関連資料については、以下を参照してください。

## ドキュメントのサポート (continued)

- 『低速またはフローティングCMOS入力の影響』、SCBA004

### 12.3 ドキュメントの更新通知を受け取る方法

ドキュメントの更新についての通知を受け取るには、[ti.com](http://ti.com)のデバイス製品フォルダを開いてください。右上の隅にある「通知を受け取る」をクリックして登録すると、変更されたすべての製品情報に関するダイジェストを毎週受け取れます。変更の詳細については、修正されたドキュメントに含まれている改訂履歴をご覧ください。

### 12.4 コミュニティ・リソース

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

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**設計サポート** TIの設計サポート役に立つE2Eフォーラムや、設計サポート・ツールをすばやく見つけることができます。技術サポート用の連絡先情報も参照できます。

### 12.5 商標

E2E is a trademark of Texas Instruments.

All other trademarks are the property of their respective owners.

### 12.6 静電気放電に関する注意事項



これらのデバイスは、限定的なESD(静電破壊)保護機能を内蔵しています。保存時または取り扱い時は、MOSゲートに対する静電破壊を防止するために、リード線同士をショートさせておくか、デバイスを導電フォームに入れる必要があります。

### 12.7 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

## 13 メカニカル、パッケージ、および注文情報

以降のページには、メカニカル、パッケージ、および注文に関する情報が記載されています。この情報は、そのデバイスについて利用可能な最新のデータです。このデータは予告なく変更されることがあり、ドキュメントが改訂される場合もあります。本データシートのブラウザ版を使用されている場合は、画面左側の説明をご覧ください。

**PACKAGING INFORMATION**

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
TS3A5018D	LIFEBUY	SOIC	D	16	40	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TS3A5018	
TS3A5018DBQR	ACTIVE	SSOP	DBQ	16	2500	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	YA018	Samples
TS3A5018DBQRG4	LIFEBUY	SSOP	DBQ	16	2500	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	YA018	
TS3A5018DE4	LIFEBUY	SOIC	D	16	40	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TS3A5018	
TS3A5018DGVR	ACTIVE	TVSOP	DGV	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	YA018	Samples
TS3A5018DR	ACTIVE	SOIC	D	16	2500	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	TS3A5018	Samples
TS3A5018PW	LIFEBUY	TSSOP	PW	16	90	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	YA018	
TS3A5018PWG4	LIFEBUY	TSSOP	PW	16	90	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	YA018	
TS3A5018PWR	ACTIVE	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	YA018	Samples
TS3A5018PWRE4	LIFEBUY	TSSOP	PW	16	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	YA018	
TS3A5018RGYR	ACTIVE	VQFN	RGY	16	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	YA018	Samples
TS3A5018RSVR	ACTIVE	UQFN	RSV	16	3000	RoHS & Green	NIPDAU   NIPDAUAG	Level-1-260C-UNLIM	-40 to 85	ZUN	Samples

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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**TAPE AND REEL INFORMATION**

**QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE**


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TS3A5018DBQR	SSOP	DBQ	16	2500	330.0	12.5	6.4	5.2	2.1	8.0	12.0	Q1
TS3A5018DGVR	TVSOP	DGV	16	2000	330.0	12.4	6.8	4.0	1.6	8.0	12.0	Q1
TS3A5018DR	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
TS3A5018PWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
TS3A5018RGYR	VQFN	RGY	16	3000	330.0	12.4	3.8	4.3	1.5	8.0	12.0	Q1
TS3A5018RSVR	UQFN	RSV	16	3000	177.8	12.4	2.0	2.8	0.7	4.0	12.0	Q1
TS3A5018RSVR	UQFN	RSV	16	3000	180.0	12.4	2.1	2.9	0.75	4.0	12.0	Q1
TS3A5018RSVR	UQFN	RSV	16	3000	180.0	13.2	2.1	2.9	0.75	4.0	12.0	Q1



**TAPE AND REEL BOX DIMENSIONS**


\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
TS3A5018DBQR	SSOP	DBQ	16	2500	340.5	338.1	20.6
TS3A5018DGVR	TVSOP	DGV	16	2000	356.0	356.0	35.0
TS3A5018DR	SOIC	D	16	2500	340.5	336.1	32.0
TS3A5018PWR	TSSOP	PW	16	2000	356.0	356.0	35.0
TS3A5018RGYR	VQFN	RGY	16	3000	356.0	356.0	35.0
TS3A5018RSVR	UQFN	RSV	16	3000	202.0	201.0	28.0
TS3A5018RSVR	UQFN	RSV	16	3000	200.0	183.0	25.0
TS3A5018RSVR	UQFN	RSV	16	3000	184.0	184.0	19.0

**TUBE**


\*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (μm)	B (mm)
TS3A5018D	D	SOIC	16	40	507	8	3940	4.32
TS3A5018DE4	D	SOIC	16	40	507	8	3940	4.32
TS3A5018PW	PW	TSSOP	16	90	530	10.2	3600	3.5
TS3A5018PWG4	PW	TSSOP	16	90	530	10.2	3600	3.5

D (R-PDSO-G16)

PLASTIC SMALL OUTLINE



- NOTES:
- A. All linear dimensions are in inches (millimeters).
  - B. This drawing is subject to change without notice.
  - C. Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
  - D. Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
  - E. Reference JEDEC MS-012 variation AC.



4220204/A 02/2017

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-153.

# EXAMPLE BOARD LAYOUT

PW0016A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE: 10X



SOLDER MASK DETAILS

4220204/A 02/2017

NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

# EXAMPLE STENCIL DESIGN

PW0016A

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL  
SCALE: 10X

4220204/A 02/2017

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

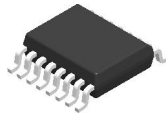
DGV (R-PDSO-G\*\*)

PLASTIC SMALL-OUTLINE

24 PINS SHOWN



- NOTES: A. All linear dimensions are in millimeters.  
 B. This drawing is subject to change without notice.  
 C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.  
 D. Falls within JEDEC: 24/48 Pins – MO-153  
 14/16/20/56 Pins – MO-194



# PACKAGE OUTLINE

## DBQ0016A

### SSOP - 1.75 mm max height

SHRINK SMALL-OUTLINE PACKAGE



#### NOTES:

1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 inch, per side.
4. This dimension does not include interlead flash.
5. Reference JEDEC registration MO-137, variation AB.

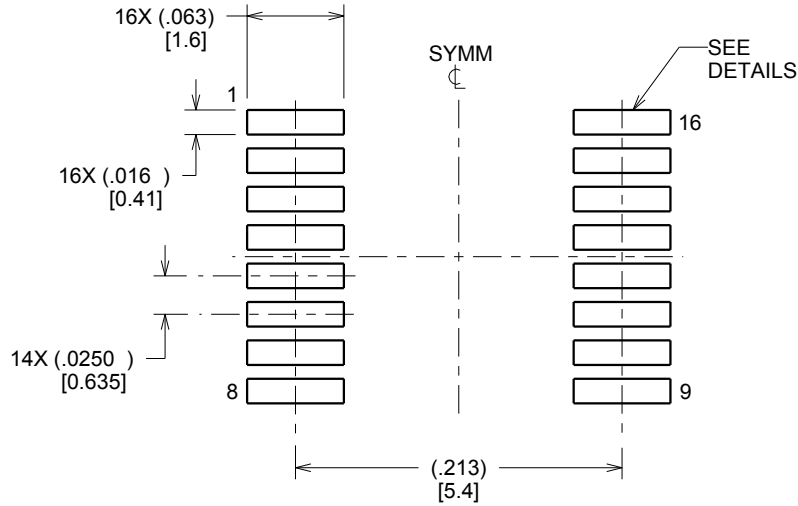


# EXAMPLE BOARD LAYOUT

DBQ0016A

SSOP - 1.75 mm max height

SHRINK SMALL-OUTLINE PACKAGE



LAND PATTERN EXAMPLE  
SCALE:8X



SOLDER MASK DETAILS

4214846/A 03/2014

NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

# EXAMPLE STENCIL DESIGN

DBQ0016A

SSOP - 1.75 mm max height

SHRINK SMALL-OUTLINE PACKAGE



SOLDER PASTE EXAMPLE  
BASED ON .005 INCH [0.127 MM] THICK STENCIL  
SCALE:8X

4214846/A 03/2014

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

RGY (R-PVQFN-N16)

PLASTIC QUAD FLATPACK NO-LEAD



4203539-3/1 06/2011

- NOTES:
- All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994.
  - This drawing is subject to change without notice.
  - QFN (Quad Flatpack No-Lead) package configuration.
  - The package thermal pad must be soldered to the board for thermal and mechanical performance.
  - See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
  - Pin 1 identifiers are located on both top and bottom of the package and within the zone indicated. The Pin 1 identifiers are either a molded, marked, or metal feature.
  - Package complies to JEDEC MO-241 variation BA.

RGY (R-PVQFN-N16)

PLASTIC QUAD FLATPACK NO-LEAD

**THERMAL INFORMATION**

This package incorporates an exposed thermal pad that is designed to be attached directly to an external heatsink. The thermal pad must be soldered directly to the printed circuit board (PCB). After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For information on the Quad Flatpack No-Lead (QFN) package and its advantages, refer to Application Report, QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271. This document is available at [www.ti.com](http://www.ti.com).

The exposed thermal pad dimensions for this package are shown in the following illustration.



Bottom View

Exposed Thermal Pad Dimensions

4206353-3/P 03/14

NOTE: All linear dimensions are in millimeters

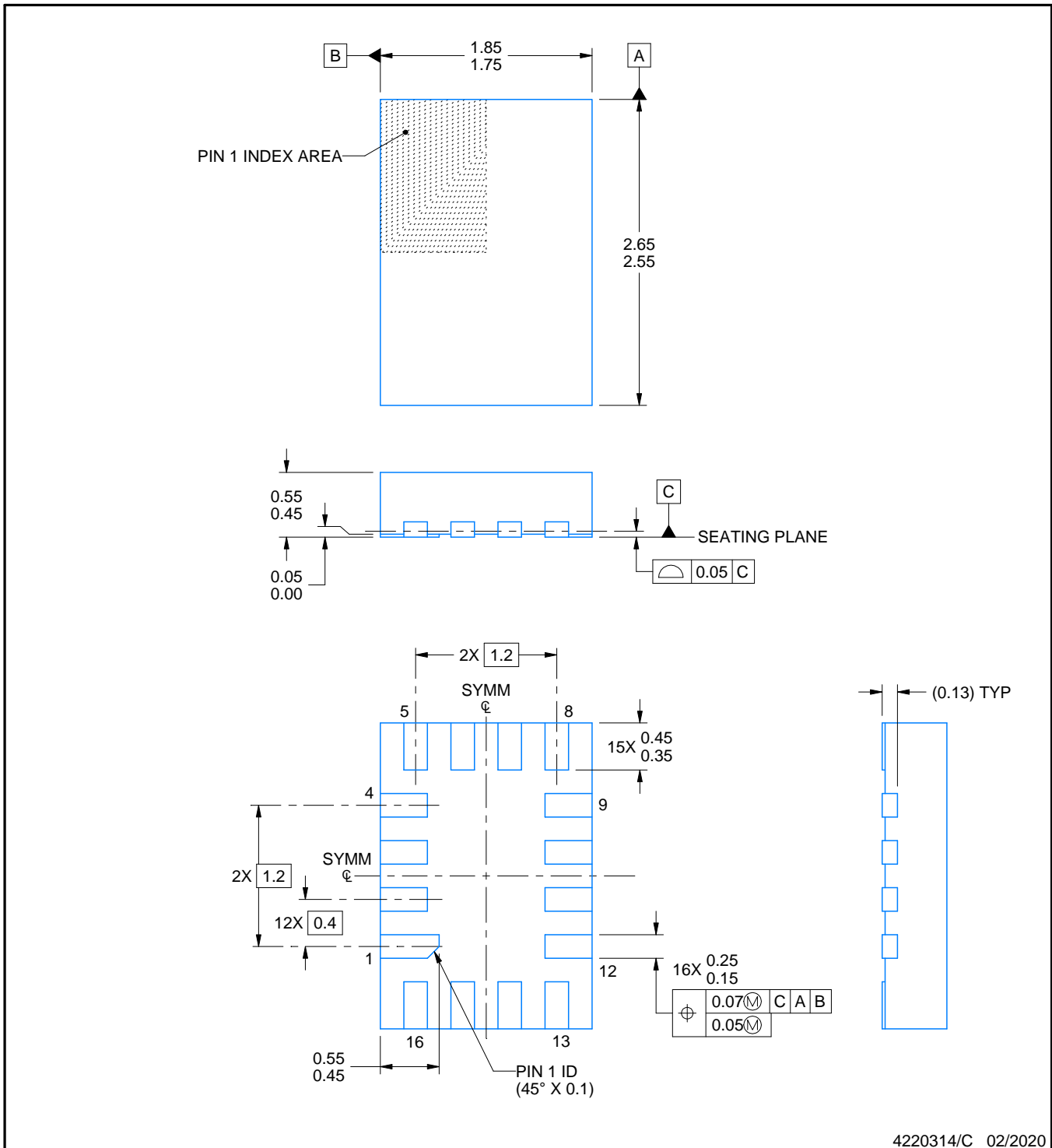
RGY (R-PVQFN-N16)

PLASTIC QUAD FLATPACK NO-LEAD



4208122-3/P 03/14

- NOTES:
- A. All linear dimensions are in millimeters.
  - B. This drawing is subject to change without notice.
  - C. Publication IPC-7351 is recommended for alternate designs.
  - D. This package is designed to be soldered to a thermal pad on the board. Refer to Application Note, Quad Flat-Pack QFN/SON PCB Attachment, Texas Instruments Literature No. SLUA271, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at [www.ti.com](http://www.ti.com) <<http://www.ti.com>>.
  - E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC 7525 for stencil design considerations.
  - F. Customers should contact their board fabrication site for minimum solder mask web tolerances between signal pads.



4220314/C 02/2020

NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.

# EXAMPLE BOARD LAYOUT

RSV0016A

UQFN - 0.55 mm max height

ULTRA THIN QUAD FLATPACK - NO LEAD



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE: 25X



4220314/C 02/2020

NOTES: (continued)

3. For more information, see Texas Instruments literature number SLUA271 ([www.ti.com/lit/slua271](http://www.ti.com/lit/slua271)).

# EXAMPLE STENCIL DESIGN

RSV0016A

UQFN - 0.55 mm max height

ULTRA THIN QUAD FLATPACK - NO LEAD



SOLDER PASTE EXAMPLE  
BASED ON 0.125 MM THICK STENCIL  
SCALE: 25X

4220314/C 02/2020

NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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